

## AONS66920

# 100V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT<sup>™</sup> technology
- Low  $R_{DS(ON)}$
- Logic Level Driving
- Excellent Q<sub>G</sub> x R<sub>DS(ON)</sub> Product (FOM)
- Skipe Optimized Process
- RoHS and Halogen-Free Compliant

Orderable Part Number

Power Dissipation B

Power Dissipation <sup>A</sup>

 $T_C = 100^{\circ}C$ 

T<sub>A</sub>=25°C

T<sub>A</sub>=70°C

Junction and Storage Temperature Range

## **Applications**

• High Frequency Switching and Synchronous Rectification

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 48A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 8.2 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 10.7 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested

Form

22.5

5.0

3.2

-55 to 150



Minimum Order Quantity

W

W

°C

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AONS66920		DFN 5x6	Tape & Reel	3000		
Absolute Maximun	n Ratings T <sub>A</sub> =2	5°C unless otherwise note	ed			
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		$V_{DS}$	100	V		
Gate-Source Voltag	e	$V_{GS}$	±20	V		
Continuous Drain	T <sub>C</sub> =25°C		48			
Current <sup>G</sup>	T <sub>C</sub> =100°C	ID	37	A		
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	125			
Continuous Drain Current	T <sub>A</sub> =25°C		17.5	A		
	T <sub>A</sub> =70°C	I <sub>DSM</sub>	14	A		
Avalanche Current	С	I <sub>AS</sub>	38	A		
Avalanche energy	L=0.1mH	C E <sub>AS</sub>	72	mJ		
	T <sub>C</sub> =25°C	В	56.5	10/		

Package Type

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	20	25	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	N <sub>θ</sub> JA	45	55	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.8	2.2	°C/W			

 $P_{DSM}$ 

 $T_J$ ,  $T_{STG}$ 



## Electrical Characteristics (T<sub>.I</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions			Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		100			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V				1	μA
D00			T <sub>J</sub> =55°C			5	μ
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$			2.0	2.5	V
	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =20A			6.7	8.2	mΩ
$R_{DS(ON)}$			T <sub>J</sub> =125°C		11.6	14	11122
		$V_{GS}$ =4.5V, $I_D$ =20A			8.5	10.7	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =20A			65		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Current					48	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance			2500		pF	
Coss	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz			485		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				13		pF
$R_g$	Gate resistance	f=1MHz		0.5	1.1	1.8	Ω
SWITCHI	NG PARAMETERS						
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge				35	50	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge	\/ . =10\/ \/ .=50\/	V 40V V 50V I 20A		16.7	25	nC
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A			8		nC
$Q_{gd}$	Gate Drain Charge				5		nC
Q <sub>oss</sub>	Output Charge	$V_{GS}$ =0V, $V_{DS}$ =50V			44		nC
t <sub>D(on)</sub>	Turn-On DelayTime				10		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_L$ =2.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			4		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				31		ns
t <sub>f</sub>	Turn-Off Fall Time				6		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			34		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, di/dt=500A/μs			170		nC

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on  $R_{0JA}$  t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

- C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150 $^{\circ}$  C.

- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with TA=25° C.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

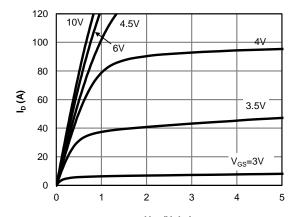
D. The R<sub>0,JA</sub> is the sum of the thermal impedance from junction to case R<sub>0,JC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

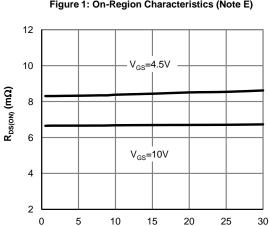
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsirk, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

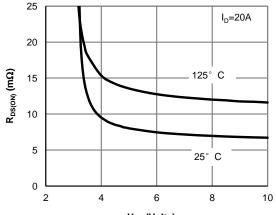


 $V_{DS}$  (Volts) Figure 1: On-Region Characteristics (Note E)

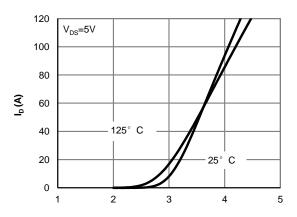


0

 $\label{eq:ldot} {\rm I_D}\left({\rm A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)

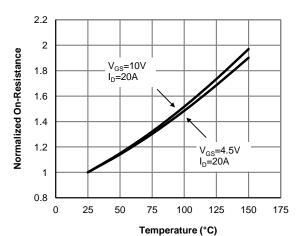
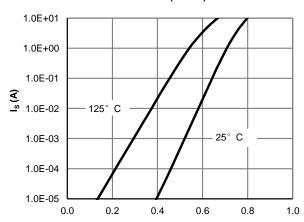


Figure 4: On-Resistance vs. Junction Temperature (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)

100

10

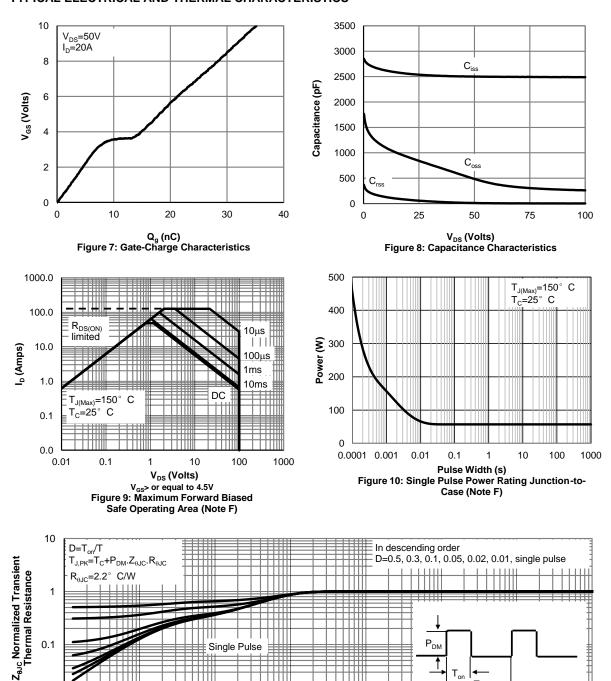


0.01

1E-05

0.0001

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

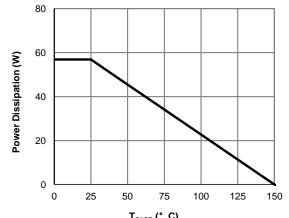
0.1

0.01

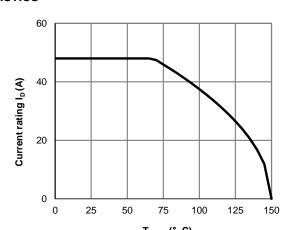
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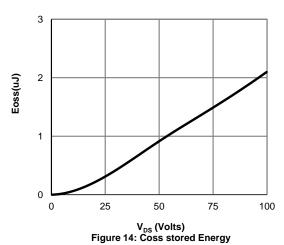
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

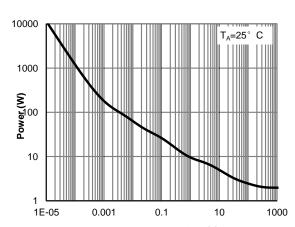


T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)

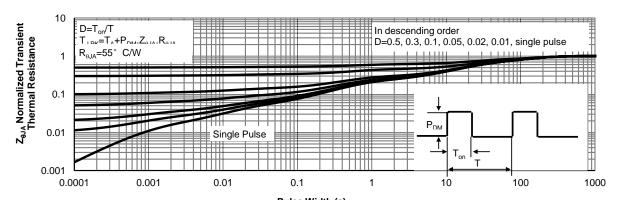


T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)





Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

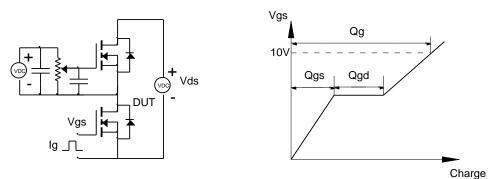


Figure B: Resistive Switching Test Circuit & Waveforms

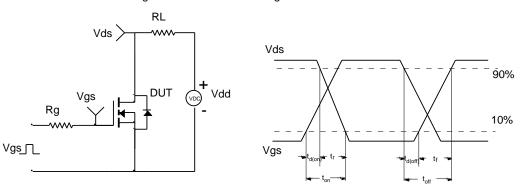


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

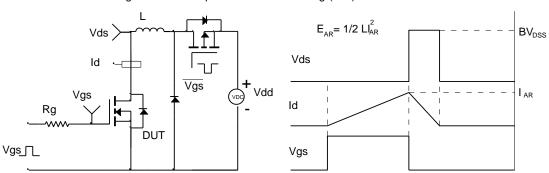


Figure D: Diode Recovery Test Circuit & Waveforms

